

Notice of References Cited	Application/Control No. 10/062,870	Applicant(s)/Patent Under Reexamination CHIU ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0059451	05-2002	Haviv, Yaron	709/238
	B	US-2002/0062402	05-2002	REGNIER et al.	709/313
	C	US-2002/0112022	08-2002	Kazar et al.	709/217
	D	US-5,485,579	01-1996	Hitz et al.	709/221
	E	US-5,838,916	11-1998	Domenikos et al.	709/219
	F	US-5,926,636	07-1999	Lam et al.	709/232
	G	US-6,356,863	03-2002	Sayle, Roger Anthony	709/219
	H	US-6,675,200	01-2004	Cheriton et al.	709/212
	I	US-6,697,878	02-2004	Imai, Yuji	709/232
	J	US-6,742,051	05-2004	Bakshi et al.	709/318
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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